

# **Amplifier Transistor** NPN Silicon

## 2N4410

#### **MAXIMUM RATINGS**

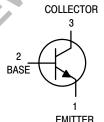
Rating	Symbol	Value	Unit	
Collector-Emitter Voltage	V <sub>CEO</sub>	80	Vdc	
Collector-Base Voltage	V <sub>CBO</sub>	120	Vdc	
Emitter-Base Voltage	V <sub>EBO</sub>	5.0	Vdc	
Collector Current — Continuous	Ic	250	mAdc	
Total Device Dissipation @ T <sub>A</sub> = 25°C Derate above 25°C	P <sub>D</sub>	625 5.0	mW mW/°C	
Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	P <sub>D</sub>	1.5 12	Watts mW/°C	
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	ŷ	



#### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Ambient	$R_{ heta JA}$	200	°C/W
Thermal Resistance, Junction to Case	$R_{ heta JC}$	83.3	°C/W

Characteristic



**ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = 25°C unless otherwise noted)

	LIVITTEIT		
Symbol	Min	Max	Unit

#### **OFF CHARACTERISTICS**

OFF CHARACTERISTICS				
Collector-Emitter Breakdown Voltage <sup>(1)</sup> (I <sub>C</sub> = 1.0 mAdc, I <sub>B</sub> = 0)	V <sub>(BR)CEO</sub>	80	_	Vdc
Collector-Emitter Breakdown Voltage ( $I_C = 500 \mu Adc$ , $V_{BE} = 5.0 Vdc$ , $R_{BE} = 8.2 k ohms$ )	V <sub>(BR)CEX</sub>	120	_	Vdc
Collector-Base Breakdown Voltage $(I_C = 10 \mu Adc, I_E = 0)$	V <sub>(BR)CBO</sub>	120	_	Vdc
Emitter–Base Breakdown Voltage $(I_E = 10 \mu Adc, I_C = 0)$	V <sub>(BR)EBO</sub>	5.0	_	Vdc
Collector Cutoff Current $(V_{CB} = 100 \text{ Vdc}, I_E = 0)$ $(V_{CB} = 100 \text{ Vdc}, I_E = 0, T_A = 100^{\circ}\text{C})$	I <sub>CBO</sub>	_	0.01 1.0	μAdc
Emitter Cutoff Current (V <sub>EB</sub> = 4.0 Vdc, I <sub>C</sub> = 0)	I <sub>EBO</sub>	_	0.1	μAdc

<sup>1.</sup> Pulse Test: Pulse Width  $\leq 300~\mu s,$  Duty Cycle  $\leq 2.0\%.$ 

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### **ELECTRICAL CHARACTERISTICS** (T<sub>A</sub> = 25°C unless otherwise noted) (Continued)

ON CHARACTERISTICS  DC Current Gain  (I <sub>C</sub> = 1.0 mAdc, V <sub>CE</sub> = 1.0 Vdc)	Symbol	Min	Max	U
$(I_C = 1.0 \text{ mAdc}, V_{CE} = 1.0 \text{ Vdc})$				
	h <sub>FE</sub>			
(1 - 10)  m/do (1 - 10)  m/do		60 60	— 400	
(I <sub>C</sub> = 10 mAdc, V <sub>CE</sub> = 1.0 Vdc)				
Collector–Emitter Saturation Voltage ( $I_C = 1.0 \text{ mAdc}$ , $I_B = 0.1 \text{ mAdc}$ )	V <sub>CE(sat)</sub>	_	0.2	٧
Base-Emitter Saturation Voltage	V <sub>BE(sat)</sub>		0.8	\
$(I_C = 1.0 \text{ mAdc}, I_B = 0.1 \text{ mAdc})$	V BE(sat)		0.0	,
Base-Emitter On Voltage	V <sub>BE(on)</sub>	_	0.8	\
$(I_C = 1.0 \text{ mAdc}, V_{CE} = 5.0 \text{ Vdc})$				
SMALL-SIGNAL CHARACTERISTICS			<b>r</b>	-
Current-Gain — Bandwidth Product <sup>(2)</sup>	f <sub>⊤</sub>	60	300	N
(I <sub>C</sub> = 10 mAdc, V <sub>CE</sub> = 10 Vdc, f = 20 MHz)				)
Collector–Base Capacitance $(V_{CB} = 10 \text{ Vdc}, I_E = 0, f = 1.0 \text{ MHz}, \text{ emitter guarded})$	C <sub>cb</sub>	_	12	
Emitter-Base Capacitance	C <sub>eb</sub>	-<	50	
$(V_{EB} = 0.5 \text{ Vdc}, I_{C} = 0, f = 1.0 \text{ MHz}, \text{ collector guarded})$				

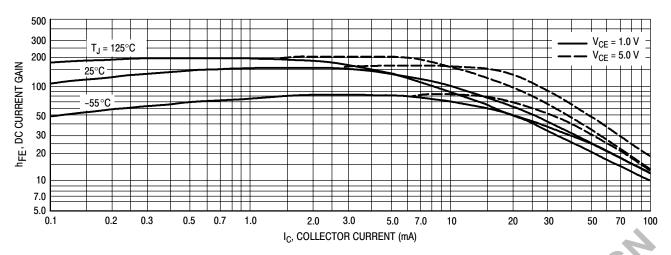


Figure 1. DC Current Gain

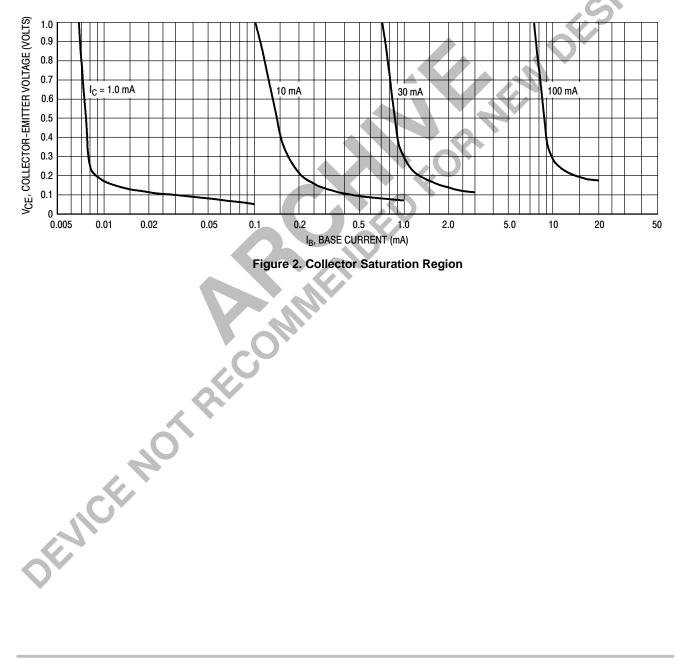


Figure 2. Collector Saturation Region

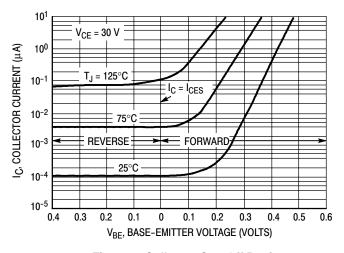


Figure 3. Collector Cut-Off Region

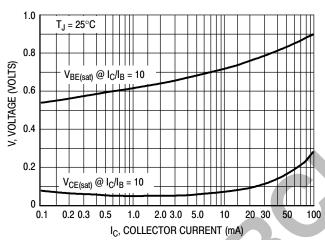


Figure 4. "On" Voltages

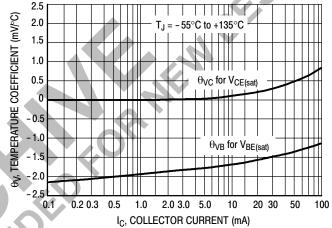


Figure 5. Temperature Coefficients

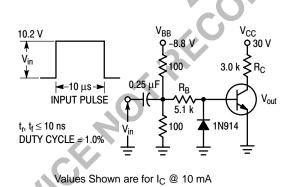


Figure 6. Switching Time Test Circuit

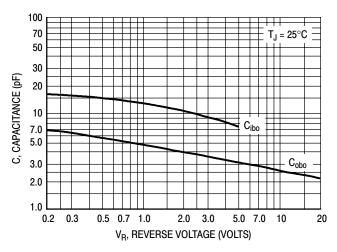
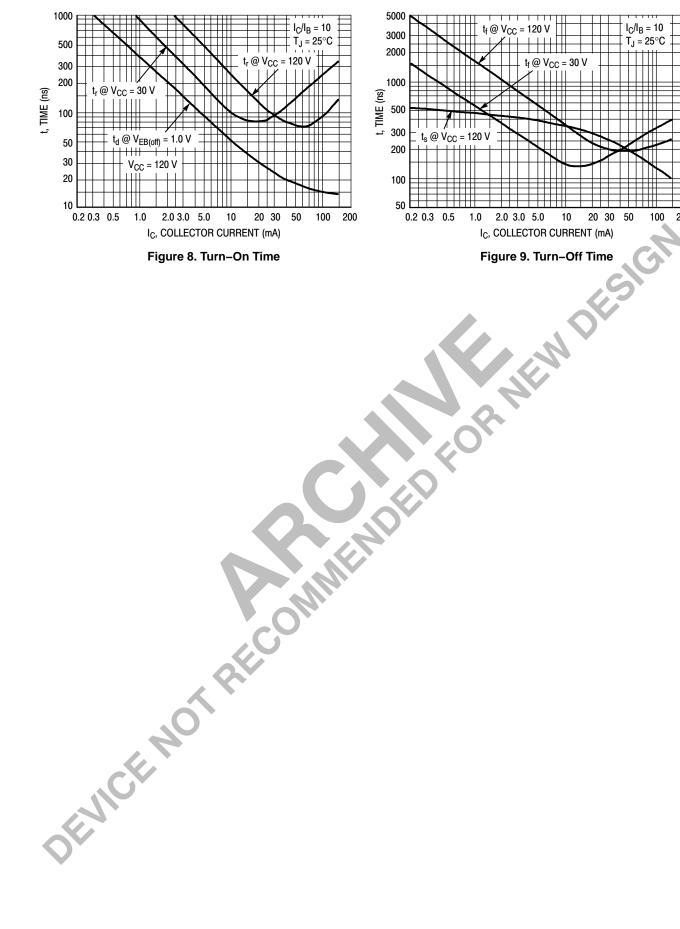
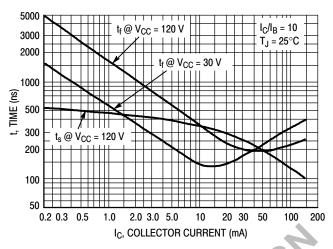


Figure 7. Capacitances

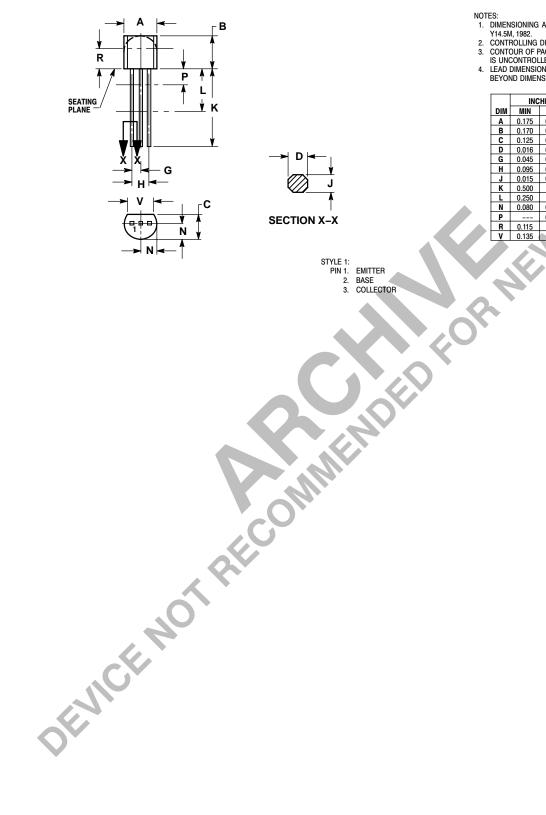
### 2N4410





#### PACKAGE DIMENSIONS

#### TO-92 (TO-226) CASÈ 29-11 **ISSUE AL**





- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- Y14.5M, 1982.

  2. CONTROLLING DIMENSION: INCH.

  3. CONTOUR OF PACKAGE BEYOND DIMENSION R
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  4. LEAD DIMENSION IS UNCONTROLLED IN P AND
- BEYOND DIMENSION K MINIMUM.

	INCHES		MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.175	0.205	4.45	5.20	
В	0.170	0.210	4.32	5.33	
С	0.125	0.165	3.18	4.19	
D	0.016	0.021	0.407	0.533	
G	0.045	0.055	1.15	1.39	
Н	0.095	0.105	2.42	2.66	
J	0.015	0.020	0.39	0.50	
K	0.500		12.70	)	
L	0.250		6.35	<u> </u>	
N	0.080	0.105	2.04	2.66	
P		0.100		2.54	
R	0.115	4	2.93		

# **Notes**





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